

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/627,742	<b>Applicant(s)/Patent under Reexamination</b> AOTSUKA, YASUO
	<b>Examiner</b> Nhan T. Tran	<b>Art Unit</b> 2622

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	1/24/2007	NT
348/222.1 (text search - see search history printout)	1/25/2007	NT
Discussed at QEM of 2622	1/24/2007	NT
Text search all classes 358 & 382 see search history printout	1/28/2007	NT
Inventorship search	1/28/2007	NT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner